

## 74ACQ377 • 54ACTQ/74ACTQ377 Quiet Series Octal D Flip-Flop with Clock Enable

### General Description

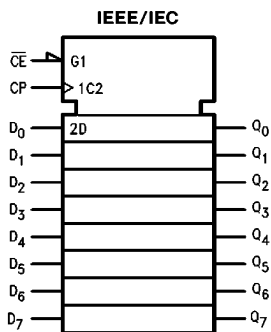
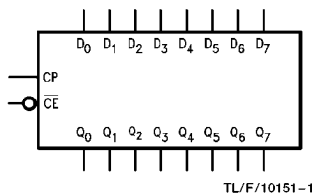
The 'ACQ/'ACTQ377 has 8 edge-triggered D-type flip-flops with individual D inputs and Q outputs. The common buffered Clock (CP) input loads all flip-flops simultaneously, when the Clock Enable ( $\overline{CE}$ ) is low. The register is fully edge-triggered. The state of each D input, one set-up time before the LOW-to-HIGH clock transition, is transferred to the corresponding flip-flop's Q output. The  $\overline{CE}$  input must be stable only one set-up time prior to the LOW-to-HIGH clock transition for predictable operation.

The 'ACQ/'ACTQ utilizes NSC Quiet Series technology to guarantee quiet output switching and improved dynamic threshold performance. FACT Quiet Series™ features GTO™ output control and undershoot corrector in addition to a split ground bus for superior performance.

### Features

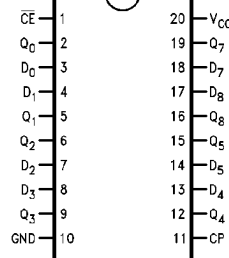
- $I_{CC}$  reduced by 50%
- Guaranteed simultaneous switching noise level and dynamic threshold performance
- Guaranteed pin-to-pin skew AC performance
- Ideal for addressable register applications
- Clock enable for address and data synchronization applications
- Eight edge-triggered D flip-flops
- Buffered common clock
- Outputs source/sink 24 mA
- Faster prop delays than the standard 'AC/'ACT377
- 4 kV minimum ESD immunity
- 'ACTQ has TTL-compatible inputs
- Standard Military Drawing (SMD)  
54ACTQ377: 5962-9219001

### Logic Symbols



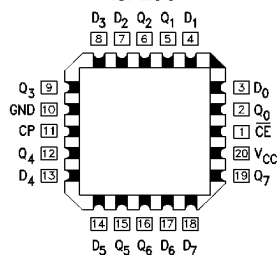
### Connection Diagrams

#### Pin Assignment for DIP, Flatpak and SOIC



Pin Names	Description
D <sub>0</sub> -D <sub>7</sub>	Data Inputs
$\overline{CE}$	Clock Enable (Active LOW)
Q <sub>0</sub> -Q <sub>7</sub>	Data Outputs
CP	Clock Pulse Input

#### Pin Assignment for LCC



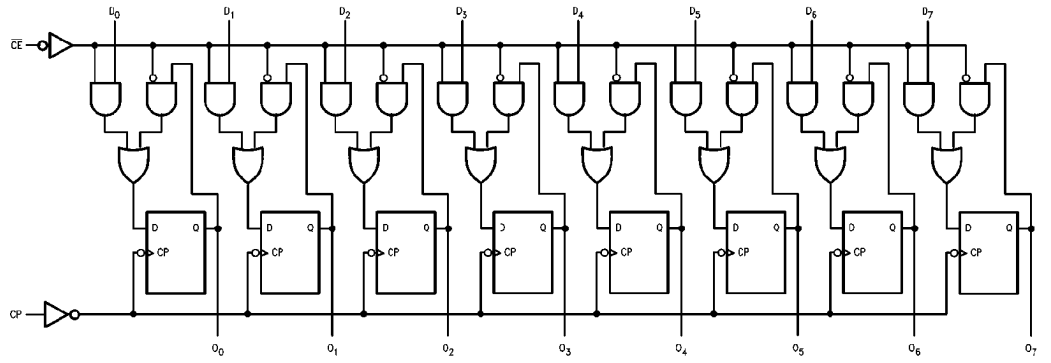
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**Mode Select-Function Table**

Operating Mode	Inputs			Outputs
	CP	$\overline{CE}$	$D_n$	$Q_n$
Load '1'	↗	L	H	H
Load '0'	↗	L	L	L
Hold (Do Nothing)	↗	H	X	No Change
	X	H	X	No Change

H = HIGH Voltage Level  
 L = LOW Voltage Level  
 X = Immaterial  
 ↗ = LOW-to-HIGH Clock Transition

**Logic Diagram**



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## Absolute Maximum Rating (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage ( $V_{CC}$ )	-0.5V to +7.0V
DC Input Diode Current ( $I_{IK}$ )	
$V_I = -0.5V$	-20 mA
$V_I = V_{CC} + 0.5V$	+20 mA
DC Input Voltage ( $V_I$ )	-0.5V to $V_{CC} + 0.5V$
DC Output Diode Current ( $I_{OK}$ )	
$V_O = -0.5V$	-20 mA
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage ( $V_O$ )	-0.5V to to $V_{CC} + 0.5V$
DC Output Source or Sink Current ( $I_O$ )	±50 mA
DC $V_{CC}$ or Ground Current per Output Pin ( $I_{CC}$ or $I_{GND}$ )	±50 mA
Storage Temperature ( $T_{STG}$ )	-65°C to +150°C
DC Latch-up Source or Sink Current	±300 mA
Junction Temperature ( $T_J$ )	
CDIP	175°C
PDIP	140°C

**Note 1:** Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT™ circuits outside databook specifications.

## Recommended Operating Conditions

Supply Voltage ( $V_{CC}$ )	
'ACQ	2.0V to 6.0V
'ACTQ	4.5V to 5.5V
Input Voltage ( $V_I$ )	0V to $V_{CC}$
Output Voltage ( $V_O$ )	0V to $V_{CC}$
Operating Temperature ( $T_A$ )	
74ACQ/ACTQ	-40°C to +85°C
54ACTQ	-55°C to +125°C
Minimum Input Edge Rate $\Delta V/\Delta t$	
'ACQ Devices	
$V_{IN}$ from 30% to 70% of $V_{CC}$	
$V_{CC}$ @ 3.0V, 4.5V, 5.5V	125 mV/ns
Minimum Input Edge Rate $\Delta V/\Delta t$	
'ACTQ Devices	
$V_{IN}$ from 0.8V to 2.0V	
$V_{CC}$ @ 4.5V, 5.5V	125 mV/ns

**Note:** All commercial packaging is not recommended for applications requiring greater than 2000 temperature cycles from -40°C to +125°C.

## DC Characteristics for 'ACQ Family Devices

Symbol	Parameter	$V_{CC}$ (V)	74ACQ		74ACQ		Units	Conditions
			$T_A = +25^\circ\text{C}$		$T_A = -40^\circ\text{C to } +85^\circ\text{C}$			
			Typ	Guaranteed Limits				
$V_{IH}$	Minimum High Level Input Voltage	3.0	1.5	2.1	2.1		V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	2.25	3.15	3.15			
		5.5	2.75	3.85	3.85			
$V_{IL}$	Maximum Low Level Input Voltage	3.0	1.5	0.9	0.9		V	$V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$
		4.5	2.25	1.35	1.35			
		5.5	2.75	1.65	1.65			
$V_{OH}$	Minimum High Level Output Voltage	3.0	2.99	2.9	2.9		V	$I_{OUT} = -50 \mu\text{A}$
		4.5	4.49	4.4	4.4			
		5.5	5.49	5.4	5.4			
$V_{OL}$	Maximum Low Level Output Voltage	3.0	0.002	0.1	0.1		V	$I_{OUT} = 50 \mu\text{A}$
		4.5	0.001	0.1	0.1			
		5.5	0.001	0.1	0.1			
$V_{OL}$	Maximum Low Level Output Voltage	3.0		0.36	0.44		V	$I_{OL}$ 24 mA
		4.5		0.36	0.44			
		5.5		0.36	0.44			
$I_{IN}$	Maximum Input Leakage Current	5.5		±0.1	±1.0		μA	$V_I = V_{CC}$ , GND (Note 1)

\*All outputs loaded; thresholds on input associated with output under test.

### DC Characteristics for 'ACQ Family Devices (Continued)

Symbol	Parameter	V <sub>CC</sub> (V)	74ACQ		74ACQ		Units	Conditions
			T <sub>A</sub> = +25°C		T <sub>A</sub> = -40°C to +85°C			
			Typ	Guaranteed Limits				
I <sub>OLD</sub>	†Minimum Dynamic Output Current	5.5			75		mA	V <sub>OLD</sub> = 1.65V Max
I <sub>OHD</sub>		5.5			-75		mA	V <sub>OHD</sub> = 3.85V Min
I <sub>CC</sub>	Maximum Quiescent Supply Current	5.5		4.0	40.0		μA	V <sub>IN</sub> = V <sub>CC</sub> or GND (Note 1)
V <sub>OLP</sub>	Quiet Output Maximum Dynamic V <sub>OL</sub>	5.0	1.1	1.5			V	Figures 2-12, 13 (Notes 2, 3)
V <sub>OLV</sub>	Quiet Output Minimum Dynamic V <sub>OL</sub>	5.0	-0.6	-1.2			V	Figures 2-12, 13 (Notes 2, 3)
V <sub>IHD</sub>	Minimum High Level Dynamic Input Voltage	5.0	3.1	3.5			V	(Notes 2, 4)
V <sub>ILD</sub>	Maximum Low Level Dynamic Input Voltage	5.0	1.9	1.5			V	(Notes 2, 4)

†Maximum test duration 2.0 ms, one output loaded at a time.

**Note 1:** I<sub>IN</sub> and I<sub>CC</sub> @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V<sub>CC</sub>.

**Note 2:** Plastic DIP package.

**Note 3:** Max number of outputs defined as (n). Data Inputs are driven 0V to 5V. One output @ GND.

**Note 4:** Max number of Data Inputs (n) switching. (n-1) Inputs switching 0V to 5V ('ACQ). Input-under-test switching: 5V to threshold (V<sub>ILD</sub>), 0V to threshold (V<sub>IHD</sub>). f = 1 MHz.

## DC Characteristics for 'ACTQ Family Devices

Symbol	Parameter	V <sub>CC</sub> (V)	74ACTQ		54ACTQ	74ACTQ	Units	Conditions
			T <sub>A</sub> = +25°C		T <sub>A</sub> = -55°C to +125°C	T <sub>A</sub> = -40°C to +85°C		
			Typ	Guaranteed Limits				
V <sub>IH</sub>	Minimum High Level Input Voltage	4.5 5.5	1.5 1.5	2.0 2.0	2.0 2.0	2.0 2.0	V	V <sub>OUT</sub> = 0.1V or V <sub>CC</sub> - 0.1V
V <sub>IL</sub>	Maximum Low Level Input Voltage	4.5 5.5	1.5 1.5	0.8 0.8	0.8 0.8	0.8 0.8	V	V <sub>OUT</sub> = 0.1V or V <sub>CC</sub> - 0.1V
V <sub>OH</sub>	Minimum High Level Output Voltage	4.5 5.5	4.49 5.49	4.4 5.4	4.4 5.4	4.4 5.4	V	I <sub>OUT</sub> = -50 μA
		4.5 5.5		3.86 4.86	3.70 4.70	3.76 4.76	V	*V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> I <sub>OH</sub> = -24 mA -24 mA
V <sub>OL</sub>	Maximum Low Level Output Voltage	4.5 5.5	0.001 0.001	0.1 0.1	0.1 0.1	0.1 0.1	V	I <sub>OUT</sub> = 50 μA
		4.5 5.5		0.36 0.36	0.50 0.50	0.44 0.44	V	*V <sub>IN</sub> = V <sub>IL</sub> or V <sub>IH</sub> I <sub>OL</sub> = 24 mA 24 mA
I <sub>IN</sub>	Maximum Input Leakage Current	5.5		±0.1	±1.0	±1.0	μA	V <sub>I</sub> = V <sub>CC</sub> , GND
I <sub>CCT</sub>	Maximum I <sub>CC</sub> /Input	5.5	0.6		1.6	1.5	mA	V <sub>I</sub> = V <sub>CC</sub> - 2.1V
I <sub>OLD</sub>	†Minimum Dynamic Output Current	5.5			50	75	mA	V <sub>OLD</sub> = 1.65V Max
I <sub>OHD</sub>		5.5			-50	-75	mA	V <sub>OHD</sub> = 3.85V Min
I <sub>CC</sub>	Maximum Quiescent Supply Current	5.5		4.0	80.0	40.0	μA	V <sub>IN</sub> = V <sub>CC</sub> or GND (Note 1)
V <sub>OLP</sub>	Quiet Output Maximum Dynamic V <sub>OL</sub>	5.0	1.1	1.5			V	Figures 2-12, 13 (Notes 2, 3)
V <sub>OLV</sub>	Quiet Output Minimum Dynamic V <sub>OL</sub>	5.0	-0.6	-1.2			V	Figures 2-12, 13 (Notes 2, 3)
V <sub>IHD</sub>	Minimum High Level Dynamic Input Voltage	5.0	1.9	2.2			V	(Notes 2, 4)
V <sub>ILD</sub>	Maximum Low Level Dynamic Input Voltage	5.0	1.2	0.8			V	(Notes 2, 4)

\*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

**Note 1:** I<sub>CC</sub> for 54ACTQ @ 25°C is identical to 74ACTQ @ 25°C.

**Note 2:** Plastic DIP package.

**Note 3:** Max number of outputs defined as (n). (n - 1) Data Inputs are driven 0V to 3V; one output @ GND.

**Note 4:** Max number of Data Inputs (n) switching. (n - 1) Inputs switching 0V to 3V (ACTQ). Input-under-test switching: 3V to threshold (V<sub>ILD</sub>), 0V to threshold (V<sub>IHD</sub>), f = 1 MHz.

## AC Electrical Characteristics

Symbol	Parameter	V <sub>CC</sub> * (V)	74ACQ			74ACQ		Units
			T <sub>A</sub> = +25°C C <sub>L</sub> = 50 pF			T <sub>A</sub> = -40°C to +85°C C <sub>L</sub> = 50 pF		
			Min	Typ	Max	Min	Max	
f <sub>max</sub>	Maximum Clock Frequency	3.3 5.0	71 95			67 91	MHz	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation Delay CP to Q <sub>n</sub>	3.3 5.0	3.0 2.0	8.0 5.5	10.0 7.5	3.0 1.5	11.0 8.0	ns
t <sub>OSSL</sub> t <sub>OSLH</sub>	Output to Output Skew** CP to Q <sub>n</sub>	3.3 5.0		1.0 0.5	1.5 1.0		1.5 1.0	ns

\*Voltage Range 5.0 is 5.0V ±0.5V  
Voltage Range 3.3 is 3.3V ±0.3V

\*\*Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs within the same package device. The specification applies to any outputs switching in the same direction, either HIGH to LOW (t<sub>OSSL</sub>) or LOW to HIGH (t<sub>OSLH</sub>). Parameter guaranteed by design. Not tested.

## AC Operating Requirements

Symbol	Parameter	V <sub>CC</sub> * (V)	74ACQ		74ACQ		Units
			T <sub>A</sub> = +25°C C <sub>L</sub> = 50 pF		T <sub>A</sub> = -40°C to +85°C C <sub>L</sub> = 50 pF		
			Typ	Guaranteed Minimum			
t <sub>s</sub>	Setup Time, HIGH or LOW D <sub>n</sub> to CP	3.3 5.0		4.0 3.5	4.0 3.5	ns	
t <sub>h</sub>	Hold Time, HIGH or LOW D <sub>n</sub> to CP	3.3 5.0		0.0 1.5	0.0 1.5	ns	
t <sub>s</sub>	Setup Time, HIGH or LOW CE to CP	3.3 5.0		5.5 4.5	5.5 4.5	ns	
t <sub>h</sub>	Hold Time, HIGH or LOW CE to CP	3.3 5.0		0.0 1.5	0.0 1.5	ns	
t <sub>w</sub>	CP Pulse Width HIGH or LOW	3.3 5.0		5.5 4.0	6.0 4.0	ns	

\*Voltage Range 5.0 is 5.0V ±0.5V  
Voltage Range 3.3 is 3.3V ±0.3V

## AC Electrical Characteristics

Symbol	Parameter	V <sub>CC</sub> * (V)	74ACTQ			54ACTQ		74ACTQ		Units
			T <sub>A</sub> = +25°C C <sub>L</sub> = 50 pF			T <sub>A</sub> = -55°C to +125°C C <sub>L</sub> = 50 pF		T <sub>A</sub> = -40°C to +85°C C <sub>L</sub> = 50 pF		
			Min	Typ	Max	Min	Max	Min	Max	
f <sub>max</sub>	Maximum Clock Frequency	5.0	87			85		83		MHz
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay CP to Q <sub>n</sub>	5.0	2.0	6.0	8.0	1.5	10.0	1.5	8.5	ns
t <sub>OSHL</sub> , t <sub>OSLH</sub>	Output to Output Skew** CP to Q <sub>n</sub>	5.0	0.5			1.0		1.0		ns

\*Voltage Range 5.0 is 5.0V ±0.5V

\*\*Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs within the same packaged device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t<sub>OSHL</sub>) or LOW-to-HIGH (t<sub>OSLH</sub>). Parameter guaranteed by design. Not tested.

## AC Operating Requirements

Symbol	Parameter	V <sub>CC</sub> * (V)	74ACTQ		54ACTQ		74ACTQ		Units
			T <sub>A</sub> = +25°C C <sub>L</sub> = 50 pF		T <sub>A</sub> = -55°C to +125°C C <sub>L</sub> = 50 pF		T <sub>A</sub> = -40°C to +85°C C <sub>L</sub> = 50 pF		
			Typ	Guaranteed Minimum					
t <sub>s</sub>	Setup Time, HIGH or LOW D <sub>n</sub> to CP	5.0		3.5	4.0	3.5			ns
t <sub>h</sub>	Hold Time, HIGH or LOW D <sub>n</sub> to CP	5.0		1.5	1.5	1.5			ns
t <sub>s</sub>	Setup Time, HIGH or LOW CE to CP	5.0		4.5	5.0	4.5			ns
t <sub>h</sub>	Hold Time, HIGH or LOW CE to CP	5.0		1.5	1.5	1.5			ns
t <sub>w</sub>	CP Pulse Width HIGH or LOW	5.0		4.0	5.0	4.0			ns

\*Voltage Range 5.0 is 5.0V ±0.5V

## Capacitance

Symbol	Parameter	Typ	Units	Conditions
C <sub>IN</sub>	Input Capacitance	4.5	pF	V <sub>CC</sub> = OPEN
C <sub>PD</sub>	Power Dissipation Capacitance	45.0	pF	V <sub>CC</sub> = 5.0V

## FACT Noise Characteristics

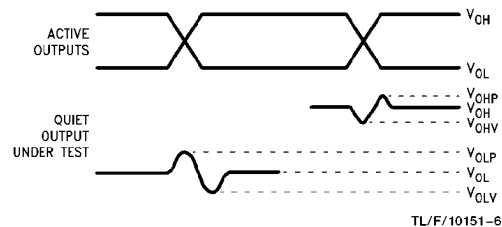
The setup of a noise characteristics measurement is critical to the accuracy and repeatability of the tests. The following is a brief description of the setup used to measure the noise characteristics of FACT.

### Equipment:

Hewlett Packard Model 8180A Word Generator  
PC-163A Test Fixture  
Tektronics Model 7854 Oscilloscope

### Procedure:

1. Verify Test Fixture Loading: Standard Load 50 pF, 500Ω.
2. Deskew the word generator so that no two channels have greater than 150 ps skew between them. This requires that the oscilloscope be deskewed first. Swap out the channels that have more than 150 ps of skew until all channels being used are within 150 ps. It is important to deskew the word generator channels before testing. This will ensure that the outputs switch simultaneously.
3. Terminate all inputs and outputs to ensure proper loading of the outputs and that the input levels are at the correct voltage.
4. Set  $V_{CC}$  to 5.0V.
5. Set the word generator to toggle all but one output at a frequency of 1 MHz. Greater frequencies will increase DUT heating and affect the results of the measurement.



**FIGURE 8. Quiet Output Noise Voltage Waveforms**

**Note A.**  $V_{OHV}$  and  $V_{OLP}$  are measured with respect to ground reference.

**Note B.** Input pulses have the following characteristics:  $f = 1$  MHz,

$t_r = 3$  ns,  $t_f = 3$  ns, skew < 150 ps.

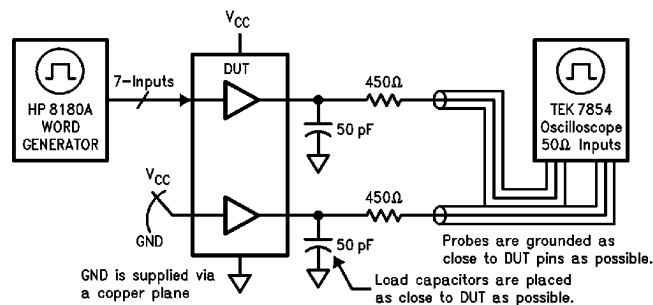
6. Set the word generator input levels at 0V LOW and 3V HIGH for ACT devices and 0V LOW and 5V HIGH for AC devices. Verify levels with a digital volt meter.

### $V_{OLP}/V_{OLV}$ and $V_{OHP}/V_{OHV}$ :

- Determine the quiet output pin that demonstrates the greatest noise levels. The worst case pin will usually be the furthest from the ground pin. Monitor the output voltages using a 50Ω coaxial cable plugged into a standard SMB type connector on the test fixture. Do not use an active FET probe.
- Measure  $V_{OLP}$  and  $V_{OLV}$  on the quiet output during the HL transition. Measure  $V_{OHP}$  and  $V_{OHV}$  on the quiet output during the LH transition.
- Verify that the GND reference recorded on the oscilloscope has not drifted to ensure the accuracy and repeatability of the measurements.

### $V_{ILD}$ and $V_{IHD}$ :

- Monitor one of the switching outputs using a 50Ω coaxial cable plugged into a standard SMB type connector on the test fixture. Do not use an active FET probe.
- First increase the input LOW voltage level,  $V_{IL}$ , until the output begins to oscillate. Oscillation is defined as noise on the output LOW level that exceeds  $V_{IL}$  limits, or on output HIGH levels that exceed  $V_{IH}$  limits. The input LOW voltage level at which oscillation occurs is defined as  $V_{ILD}$ .
- Next increase the input HIGH voltage level on the word generator,  $V_{IH}$  until the output begins to oscillate. Oscillation is defined as noise on the output LOW level that exceeds  $V_{IL}$  limits, or on output HIGH levels that exceed  $V_{IH}$  limits. The input HIGH voltage level at which oscillation occurs is defined as  $V_{IHD}$ .
- Verify that the GND reference recorded on the oscilloscope has not drifted to ensure the accuracy and repeatability on the measurements.

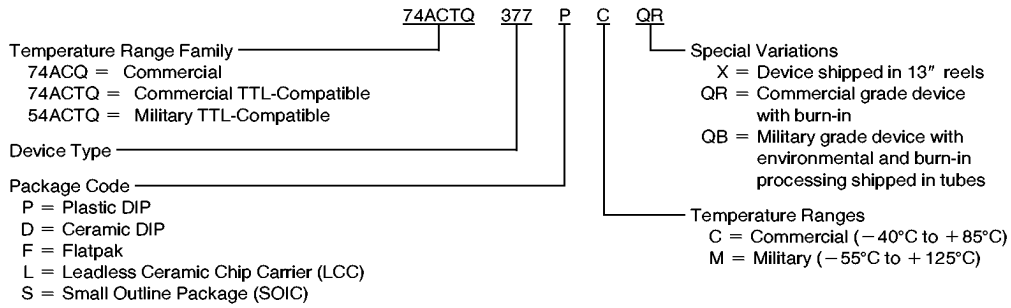


**FIGURE 9. Simultaneous Switching Test Circuit**

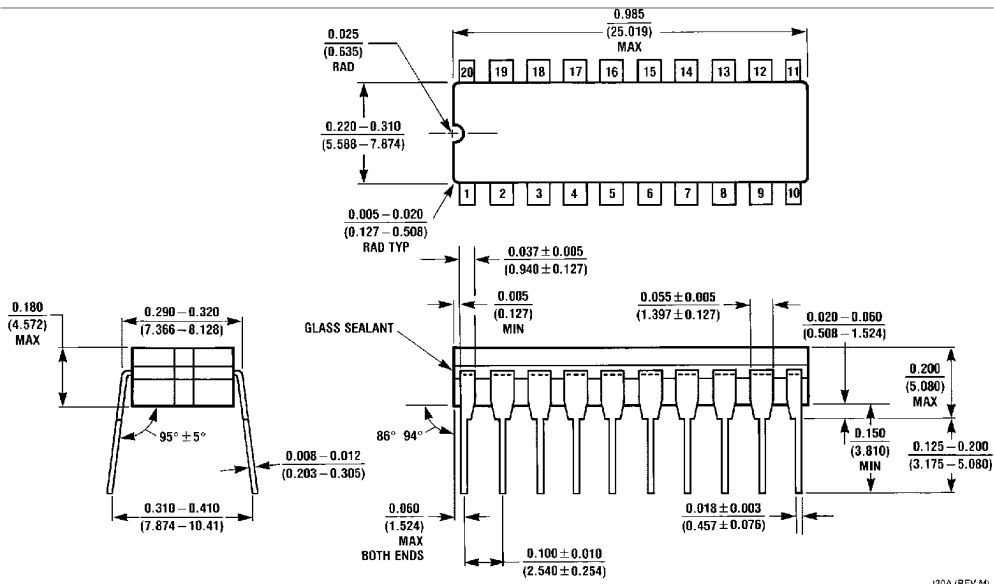


## Ordering Information

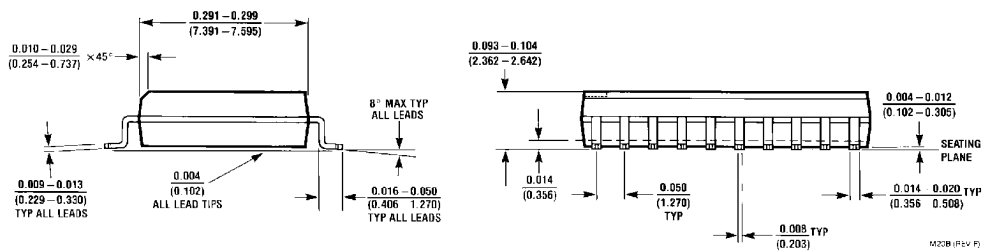
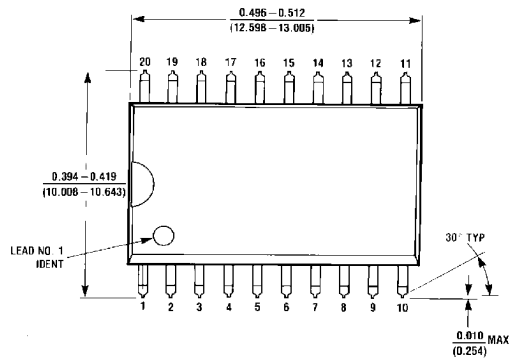
The device number is used to form part of a simplified purchasing code where the package type and temperature range are defined as follows:



**Physical Dimensions** inches (millimeters)

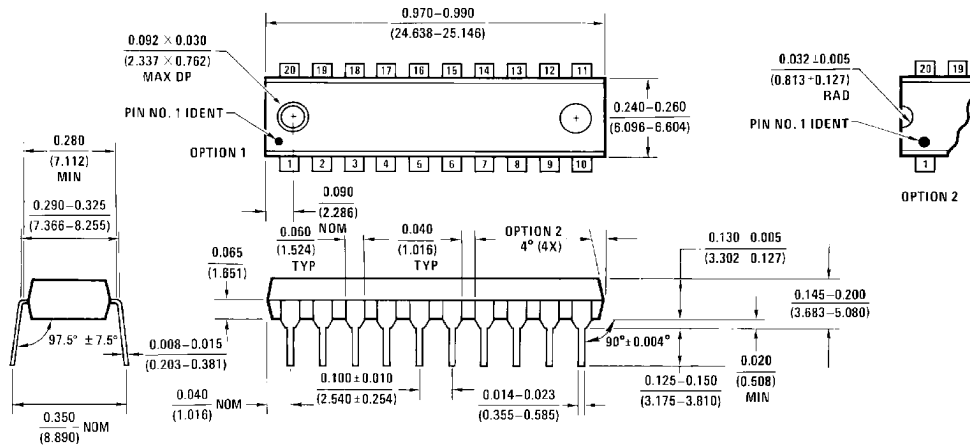


**20-Lead Ceramic Dual-In-Line Package (D)**  
**NS Package Number J20A**



**20-Lead Small Outline Integrated Circuit (S)**  
**NS Package Number M20B**

**Physical Dimensions** inches (millimeters) (Continued)

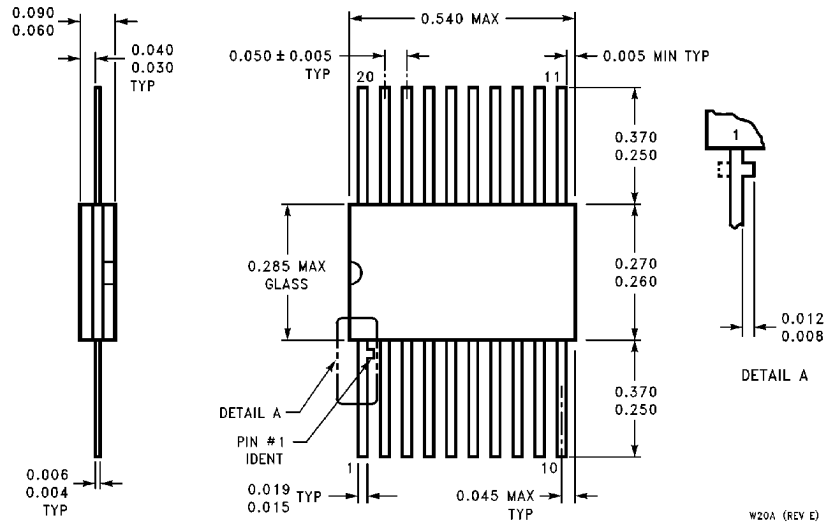


**20-Lead Plastic Dual-In-Line Package (P)**  
**NS Package Number N20B**

N20B (REV A)

**Physical Dimensions** inches (millimeters) (Continued)

Lit. # 114663



**20-Lead Ceramic Flatpak (F)  
NS Package Number W20A**

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1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform, when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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